

Notice of References Cited	Application/Control No. 10/016,633	Applicant(s)/Patent Under Reexamination PEITER ET AL.	
	Examiner Binh X Tran	Art Unit 1765	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,214,703	04-2001	Chen et al.	438/462
	B	US-6,156,676	12-2000	Sato et al.	438/798
	C	US-5,597,590	01-1997	Tanimoto et al.	425/174.4
	D	US-4,044,222	08-1977	Kestenbaum, Ami	219/121.71
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.